Ag$_2$Te thin films' structural and optical characteristics as a result of Al doping

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During the course of this investigation, Ag$_2$Te and Al-doped Ag$_2$Te films' structural and optical properties at various concentrations (1%, 1.5%) are examined. The thermal evaporation method was used to deposit 400-nm thick Ag$_2$Te thin films on glass substrates at 100 °C. The structure is monoclinic of the polycrystalline films were revealed by (XRD). Between 1 and 1.5%, the activated precursor did not vary with respect to the favored direction. According to the XRD results, the mean crystal sizes ranged from 25.62 to 37.13 nm. The surface of the film is incredibly smooth, according to atomic force microscope study (AFM). The produced films' optical characteristics were investigated. optical absorption coefficient ($\alpha$) of films were determined using the absorption spectra within the wavelength region (400-1000) nm. It was discovered that the optical energy gap allows direct transmission and that it narrows with doping. AFM was used to measure the grain size and roughness, which change when impurities are added.

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1. Introduction

Superionic conductivity and structural transitions in phase are two unique features of the I-VI semiconductor compound known as silver telluride[1]. The monoclinic structure of silver telluride at a low temperature changes structurally to the cubic structure at a high temperature[2]. It has a molar mass of 341.3364 g/mol and a density of 8.318 g/cm$^3$, a large magnetoresistance, and high electrical conductivity. It is a mixed ionic conductor with a high concentration[3]. The Quantum size effects have caused binary chalcogenide semiconductors to exhibit size-dependent optical characteristics[4]. It has numerous applications in nonlinear optical devices and switching devices. electrochemical potential memory devices [5]. Schottky barrier[6]. the photodetector, solar energy conversion, switching devices, superionic conductors [7]. Magnetic field sensing devices, and semiconducting optical device for the visible region. The crystalline structure has a monoclinic[8]. Ag$_2$Te numerous techniques to prepare it, the like hydrothermal, co-precipitation, sol-gel, and sonochemical, and deposited through heating, chemical bath deposition, solid vapor phase interaction, and vacuum evaporation the mixture of the Ag and Te at high temperature [9, 10].

2. Experimental

Ag and Te were combined to create alloys with a purity of 99.999%. Ag and Te each have a weight percentage of 1.885 gm and 1.114 gm, respectively. Then they thoroughly combined with one another in pristine quartz tubes. The tubes were sealed at a pressure of 10$^{-3}$ Torr. The tubes were put into containers and then put in an electric furnace. Stepwise temperature increases of 5 °C/min were made up to a final temperature of 1000 °C when the samples were kept for 5 hours[11]. The ingots were removed from the tubes and thoroughly ground before being used to produce thin films on glass substrates for cleaning at room temperature. Using the thermal...
evaporation process in a $10^{-5}$ Torr vacuum. The thickness of them is (400±20) with rate of deposition (2.07813nm Sec⁻¹)[12]. By using the thermal evaporation method, the Ag₂Te films were doped with the element (Al) in a ratio of (1%, 1.5%). After determining the atomic percentages, the doping element was deposited on the Ag₂Te films, and the samples were then placed in an electric furnace at 100 °C for one hour[13].

### 3. Results and discussion

#### 3.1. Structural properties

Figure 1: depicts XRD spectra of the films that were applied at a thickness of 400 nm and a temperature of 100 °C on a clean glass substrate. It was found that the pure films of (Ag₂Te) and Al-doped polycrystalline, as is typical, and had seven diffraction peaks. and the monoclinic phase's (200), (-112), (211), (-133), (-321), (020) and (013) planes (JCPDS 01-081-1985). The XRD results demonstrated that, in comparison to pure Ag₂Te, the peak intensity increases as aluminum doping concentration increases[14]. This demonstrates that an decrease in FWHM may result in an increase in the crystallization rate.

![XRD patterns](image)

**Table 1. All produced films' structural parameters were measured at a thickness of 400nm.**

<table>
<thead>
<tr>
<th>Samples</th>
<th>2 Theta (deg)</th>
<th>$\beta$ (deg)</th>
<th>$D_g$ (nm)</th>
<th>$\eta \times 10^{-4}$ (lines²×m⁻¹)</th>
<th>$\delta$ (lines/m²)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ag₂Te Pure</td>
<td>41.498</td>
<td>0.3464</td>
<td>25.62466</td>
<td>1.412311</td>
<td>1.52E+15</td>
</tr>
<tr>
<td>Ag₂Te: 1%Al</td>
<td>41.6184</td>
<td>0.2649</td>
<td>33.52193</td>
<td>1.079592</td>
<td>8.9E+14</td>
</tr>
<tr>
<td>Ag₂Te: 1.5%Al</td>
<td>41.6097</td>
<td>0.2391</td>
<td>37.13802</td>
<td>0.974473</td>
<td>7.25E+14</td>
</tr>
</tbody>
</table>

Figure 2. The impact of doping on Ag₂Te and Ag₂Te:Al film was demonstrated by calculating the surface topographic of pure Ag₂Te- doping with 1% and 1.5%. The XRD test findings and the particle size agree. Table 2 displays all of the produced films' particle sizes, surface roughness, and root mean square roughness values[15].
Fig. 2. (3D) AFM images of all films were prepared.

Table 2. All films' AFM information was created.

<table>
<thead>
<tr>
<th>Sample</th>
<th>Size of grain (nm)</th>
<th>Roughness. (nm)</th>
<th>Root mean square. (nm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ag₂Te</td>
<td>38.49</td>
<td>7.49</td>
<td>10.01</td>
</tr>
<tr>
<td>Ag₂Te:1%Al</td>
<td>41.75</td>
<td>15.87</td>
<td>20.14</td>
</tr>
<tr>
<td>Ag₂Te:1.5%Al</td>
<td>43.68</td>
<td>16.63</td>
<td>22.14</td>
</tr>
</tbody>
</table>

Figure 3: The surface morphology of all samples of pure (Ag₂Te) films and doped with (Al) was examined using (FESEM) technique with a magnification of 120 KX in order to know the nature of the film surfaces and to clarify the change in the particle size, as the pictures in Figure (3) show that impurities have additives in certain proportions have a great effect on the formation of the surface composition of the prepared films, and all the prepared films have granules with a uniform distribution, and when the percentage of doping is increased, the surface of the film is more homogeneous and regular, and thus the quality of the prepared films improves, and also the increase in the percentage of doping led to a change in the particle size as a result of the effect of impurity atoms included in the composition of the material, which indicates that increasing the percentage of doping with (Al) leads to a change in the shape of the particles crated as a result of superposition[16].
3.2. Optical properties

Figure 4 for the studied Ag$_2$Te and Al-doped Ag$_2$Te thin films with a thickness of 400 nm. It demonstrates how wavelength ($\lambda$) affects absorbance in the spectral area between 400 and 1000 nm. In the figure, the films exhibit greater absorbance on the side of shorter wavelength (UV) and less absorbance on the side of longer wavelength (visibility) and we note that the absorbance edges move to large wavelengths (red shift). Showing the photonic gap decreases with rising Al concentration. This is because there are runaway transitions in the density state in the energy gap. The sharp absorption edge opposite the band gap confirms the good quality of the as-grown films. The incoming photons in the low wavelength region have enough energy to excite electrons from the valance bands to the conducting bands and these photons are eventually absorbed by the material[17]. The photon will move because it lacks sufficient energy to interact with the atom at high wavelength. The thickness of 300nm films is measured.

Fig. 4. Optical absorption Each film's VS wavelength was created.
Fig. 5 illustrates how optical absorption coefficient changes with wavelength for the investigated pure Ag₂Te and Al doped Ag₂Te films at the spectral range from 400nm to 1000 nm. Founded on the fact that an increase in the dopant led to a little change in absorption values, as the concentration of Al rises, the values of the optical absorption coefficient rise as well. All films in the high absorption region have values more than \(10^4\) cm\(^{-1}\), which raises a direct transmission's probability.

![Absorption coefficient graph](image)

**Fig. 5. The absorption coefficient of all films were prepared.**

Fig. 6 Drawing the curves to \((\alpha h\nu)^2 = 0\) for Ag₂Te and 1% and 1.5% from Al doped Ag₂Te film yielded optical energy gap values of 1.4, 1.34, and 1.26 eV, respectively. It is possible to determine the optical energy gap of the intercept \((\alpha h\nu)^2\) VS. Photon energy \(h\nu\) for allowed direct transition. The experimental values of \(\alpha h\nu\) against Ag₂Te and Ag₂Te containing 1% and 1.5% of Al are presented. It is noted from Figure (6) the added impurity atoms led to a decrease in the value of the optical energy gap for all prepared films. This is due to the density of donor levels formed by the added impurity atoms near the conduction band. Thus, the appearance of the decrease in the value of the energy gap, although it was not large in its amount, is attributed to some of the impurity atoms added has worked on the treatment of point defects (filling fungal voids) present in the crystal structure of the compound was better, so its work was limited to improving the crystal structure and filling Lattice voids more than contribute to changing the value of the energy gap by a large amount.

![Plot of \((\alpha h\nu)^2\) VS. Photon energy (h\nu) for each film](image)

**Fig. 6. A Plot of \((\alpha h\nu)^2\) VS. Photon energy (h\nu) for each film was created.**
4. Conclusion

According to XRD results, thin films of Ag$_2$Te and Al doping that were 1% and 1.5% respectively, were polycrystalline and having a monoclinic structure. The film surface is extremely smooth, according to the AFM results. The roughness of the film surface rises with an increase in Al concentration. In the visible region, the absorption value of pure Ag$_2$Te and Al doping film reaches 90%, which is significant for its uses as solar cells. The optical energy gap of pure Ag$_2$Te thin films and containing 1% of Al and 1.5% of Ag$_2$Te was equal to 1.4, 1.34, 1.26 eV.

References